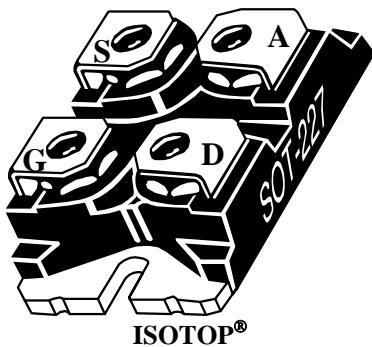
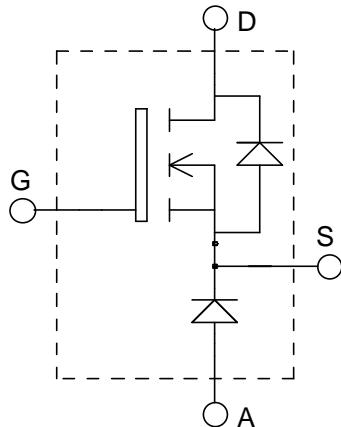


**ISOTOP® Buck chopper  
MOSFET + SiC chopper diode  
Power module**

**V<sub>DSS</sub> = 1000V**  
**R<sub>DSon</sub> = 330mΩ typ @ T<sub>j</sub> = 25°C**  
**I<sub>D</sub> = 26A @ T<sub>c</sub> = 25°C**



### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage	1000	V
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> = 25°C	A
		T <sub>c</sub> = 80°C	
I <sub>DM</sub>	Pulsed Drain current	140	
V <sub>GS</sub>	Gate - Source Voltage	±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance	396	mΩ
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> = 25°C	W
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)	18	A

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

### Application

- AC and DC motor control
- Switched Mode Power Supplies

### Features

- **Power MOS 8™ MOSFET**
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Avalanche energy rated
- **SiC Schottky Diode**
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature Independent switching behavior
  - Positive temperature coefficient on VF
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- RoHS Compliant

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

### Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 1000\text{V}$ $V_{GS} = 0\text{V}$	$T_j = 25^\circ\text{C}$			100	$\mu\text{A}$
			$T_j = 125^\circ\text{C}$			500	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}$ , $I_D = 18\text{A}$			330	396	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5\text{mA}$		3	4	5	$\text{V}$
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30\text{ V}$				$\pm 100$	$\text{nA}$

### Dynamic Characteristics

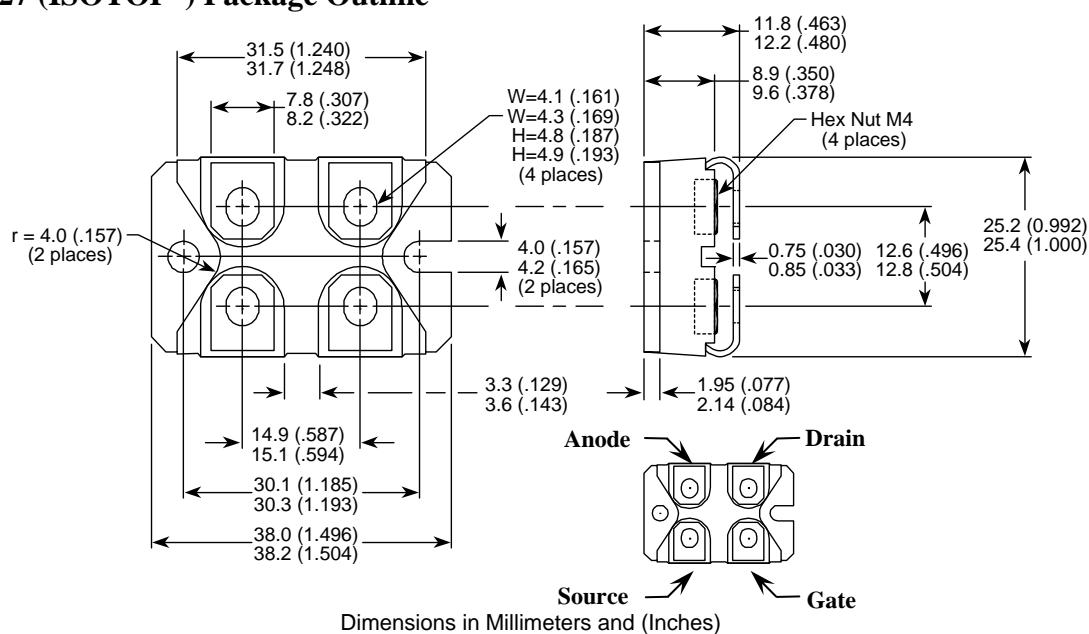
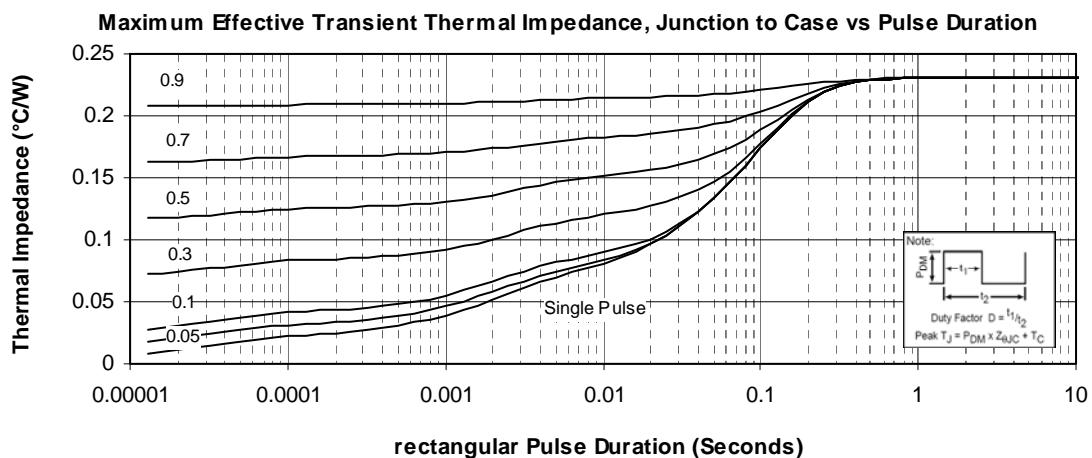
Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1\text{MHz}$			7868		$\text{pF}$
$C_{oss}$	Output Capacitance				825		
$C_{rss}$	Reverse Transfer Capacitance				104		
$Q_g$	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 500\text{V}$ $I_D = 18\text{A}$			305		$\text{nC}$
$Q_{gs}$	Gate – Source Charge				55		
$Q_{gd}$	Gate – Drain Charge				145		
$T_{d(on)}$	Turn-on Delay Time	<b>Resistive switching @ <math>25^\circ\text{C}</math></b> $V_{GS} = 15\text{V}$ $V_{Bus} = 667\text{V}$ $I_D = 18\text{A}$			44		$\text{ns}$
$T_r$	Rise Time				40		
$T_{d(off)}$	Turn-off Delay Time				150		
$T_f$	Fall Time		$R_G = 2.2\Omega$		38		

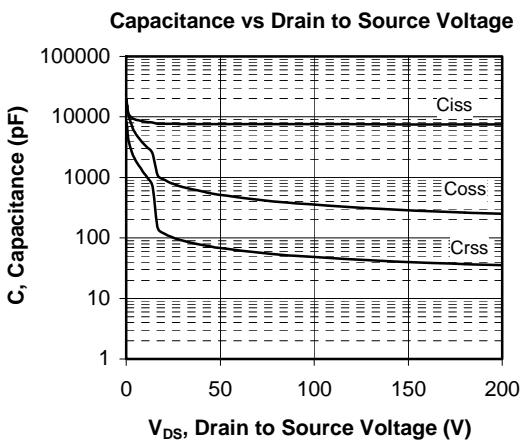
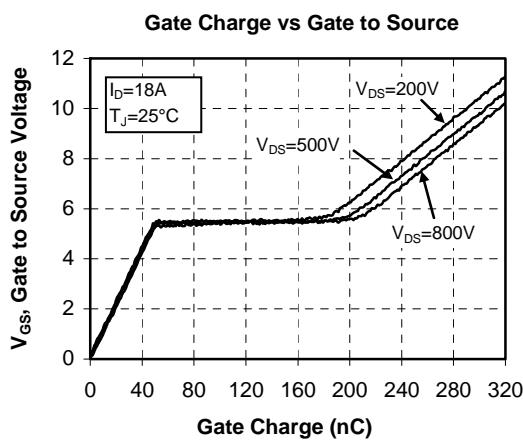
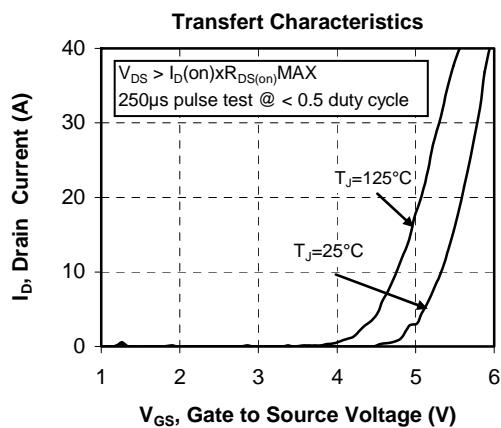
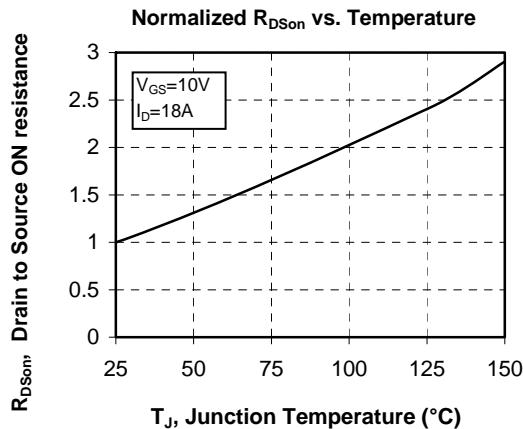
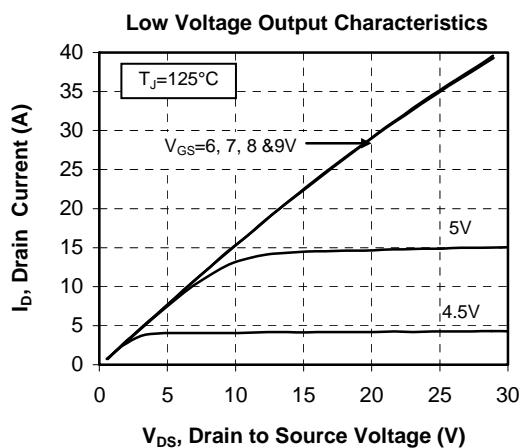
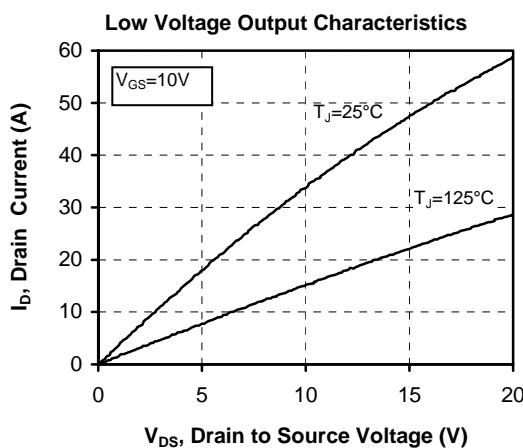
### SiC chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$	1200			$\text{V}$
$I_{RM}$	Maximum Reverse Leakage Current		$T_j = 175^\circ\text{C}$		32	200	$\mu\text{A}$
$I_F$	DC Forward Current		$T_c = 100^\circ\text{C}$		56	1000	
$V_F$	Diode Forward Voltage	$I_F = 10\text{A}$	$T_j = 25^\circ\text{C}$		1.6	1.8	$\text{V}$
			$T_j = 175^\circ\text{C}$		2.3	3	
$Q_C$	Total Capacitive Charge	$I_F = 10\text{A}$ , $V_R = 600\text{V}$ $dI/dt = 500\text{A}/\mu\text{s}$			80		$\text{nC}$
$C$	Total Capacitance		$f = 1\text{MHz}$ , $V_R = 200\text{V}$		96		$\text{pF}$
			$f = 1\text{MHz}$ , $V_R = 400\text{V}$		69		

### Thermal and package characteristics

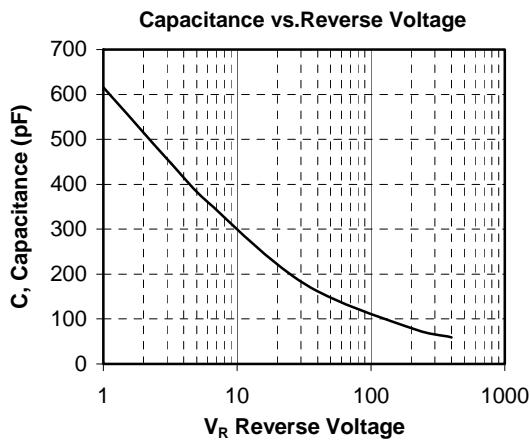
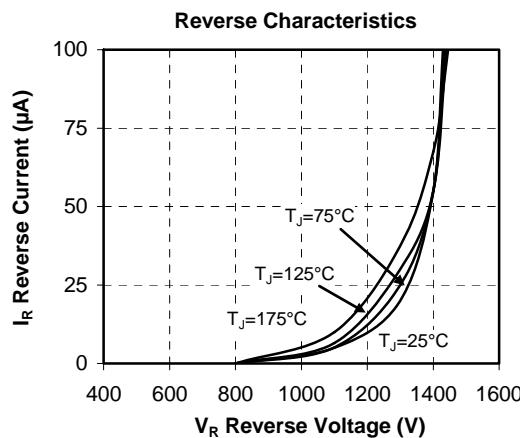
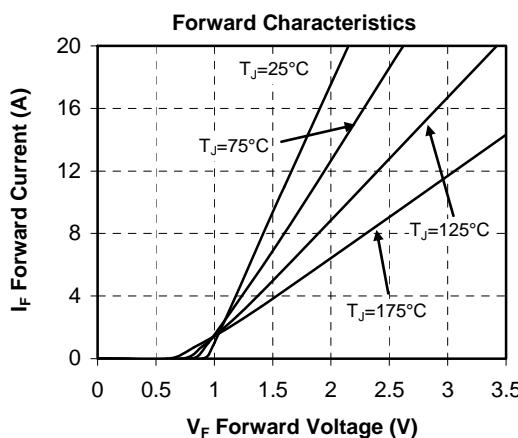
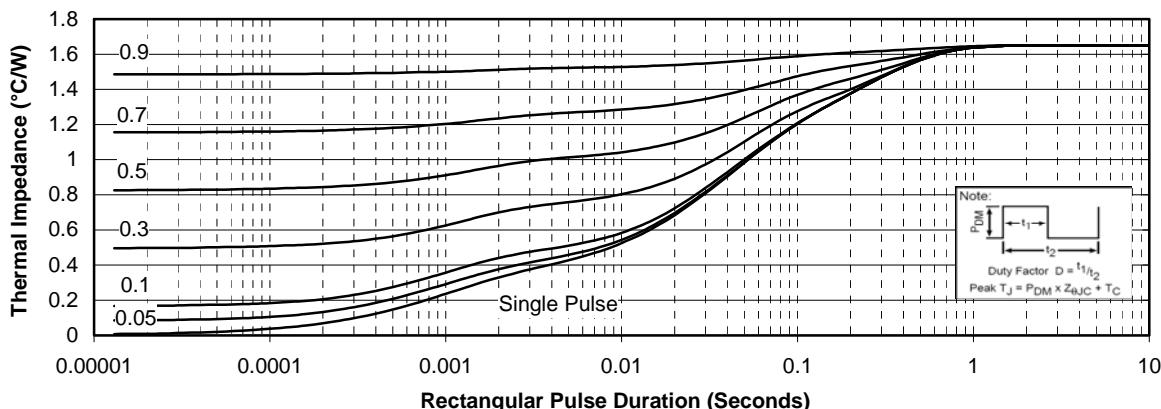
Symbol	Characteristic	Min	Typ	Max	Unit
$R_{thJC}$	Junction to Case Thermal Resistance	Mosfet		0.23	$^\circ\text{C}/\text{W}$
		SiC Diode		1.65	
$R_{thJA}$	Junction to Ambient (IGBT & Diode)			20	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, I isol < 1mA, 50/60Hz	2500			$\text{V}$
$T_i, T_{STG}$	Storage Temperature Range	-40		150	$^\circ\text{C}$
$T_L$	Max Lead Temp for Soldering: 0.063" from case for 10 sec			300	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)			1.5	$\text{N.m}$
Wt	Package Weight		29.2		$\text{g}$

**SOT-227 (ISOTOP<sup>®</sup>) Package Outline**

**Typical Mosfet Performance Curve**




### Typical SiC Diode Performance Curve

Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



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Microsemi reserves the right to change, without notice, the specifications and information contained herein

Microsemi's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 6,939,743 7,352,045 5,283,201 5,801,417 5,648,283 7,196,634 6,664,594 7,157,886 6,939,743 7,342,262 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.